

**Search Notes**

Application/Control No.

10/524,891

Examiner

CHRIS C. CHU

Applicant(s)/Patent under  
Reexamination

ASSAL ET AL.

Art Unit

2815

**SEARCHED**

Class	Subclass	Date	Examiner
257	E23.078, E23.187 & E25.016	3/24/2008	C.C.
257	E23.006	3/24/2008	C.C.
257	E23.109	3/24/2008	C.C.
257	720 & 713	3/24/2008	C.C.
257	675 & 178	3/24/2008	C.C.
257	734 & 727	3/24/2008	C.C.
257	118 & 181	3/24/2008	C.C.
257	690	3/24/2008	C.C.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched in US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; and IBM_TDB;	3/24/2008	C.C.